

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 271672US2PCT		SERIAL NO. 10/533,810	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shigeki SAKAI			
				FILING DATE September 8, 2005		GROUP 1792	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	JP 62-180063	08/07/1987	Japan (With English Abstract)			X
	AP	JP 02-163374	06/22/1990	Japan (With English Abstract)			X
	AQ	JP 60-162774	08/24/1985	Japan (With English Abstract)			X
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Deppisch, G. "Schichtdickengleichmäßigkeit von aufgestäubten Schichten - Vergleich zwischen Berechnungen und praktischen Ergebnissen" [Layer Thickness Uniformity of Spray Coated Films - Comparison Between Calculations and Practical Results]. <i>Vakuum-Technik</i> , Vol. 30, Issue 4, 1981. pp. 106 - 114.					
	AX	Greer, J.A. and Tabat, M.D. "Large-area pulsed laser deposition: Techniques and applications". <i>Journal of Vacuum Sci. Technology, A</i> 13 (3), May/June 1995. American Vacuum Society, 1995. pp. 1175-1181.					
	AY	Dietsch, R., et al. "Large area PLD of nanometer-multilayers". <i>Applied Surface Science</i> , 197-198, 2002. pp. 169-174.					
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <u>/Kelly Stouffer/</u>					Date Considered 07/28/2009		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /KMS/